

Direct Writing of Lateral Fluorographene Nanopatterns with Tunable Bandgaps and Its Application in New Generation of Moiré Superlattice

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Abstract

One of the primary goals for monolayer device fabrications and an ideal model of graphene as an atomic thin “canvas” is one that permits semiconducting/insulating lateral nanopatterns to be freely and directly drawn on the semi-metallic graphene surface [1-2]. Here, we demonstrate a reversible electron-beam-activated technique that allows direct writing of semiconducting/insulating fluorographene lateral nanopatterns with tunable bandgaps directly on the graphene surface with a resolution down to 9–15 nm [3-4]. This approach overcomes the conventional limit of semiconducting C₄F in the single-sided fluorination of supported graphene and achieves the tunability until insulating C₂F. Moreover, applying this technique on bilayer graphene demonstrates, for the first time, a new type of rectangular moiré pattern arising from the generated C₂F boat/graphene superlattice. This novel technique constitutes a new approach to fabricating graphene-based flexible and transparent electronic nanodevices with the C_xF channels utilized as semiconducting or insulating counterparts, and also opens a route toward the tailoring and engineering of electronic properties of such materials in addition to the dominating triangular moiré patterns from a graphene/hBN system.

References

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Figures

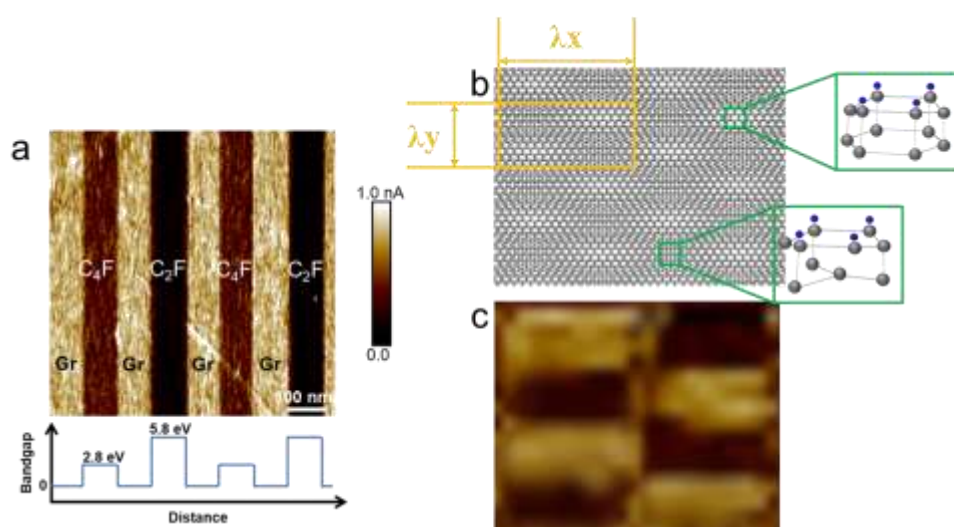


Figure 1: (a) AFM conductive mapping of nanopatterns consisting of graphene, semiconducting C₄F and insulating C₂F stripes directly written on monolayer graphene. The contrast of the mapping indicates the decreasing of the conductivity with the increased fluorine concentration. (b) Schematic of the formation of the rectangular moiré patterns for C₂F (boat)/graphene superlattice with a zero misalignment angle and exaggerated lattice mismatches. (c) Experimental AFM image of rectangular moiré patterns arising from the C₂F (boat)/graphene superlattice with the length and width of 13.8 nm and 6.8 nm, respectively.